

TOP FEATURES AND BENEFITS

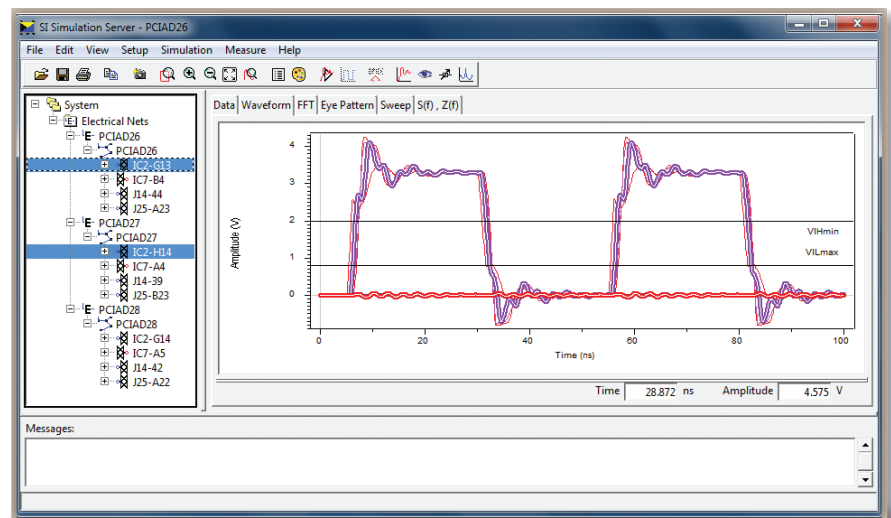
- Integrated within CADSTAR High-Speed Design suite for concurrent and post-layout SI analysis and constraint verification.
- Accurate transmission line analysis for fast calculation of reflection and crosstalk effects.
- Embedded simulation model library includes standard IC models and an IBIS 5.0 parser.
- Support for eye diagrams, frequency domain/S-Parameter simulations, and parameter sweeps.
- Time domain analysis supports frequency-dependent “skin effect” and Ohmic losses for accurate simulation into the GHz domain.
- Perform virtual measurements at the IC package pin or directly on the silicon die.
- Frequency domain simulation supports S-Parameter and transmission line impedance, with the option to export S-Parameter data in Touchstone format.

Signal Integrity CADSTAR SI Verify

Introduction

As more designs incorporate high-speed technologies and involve integrated circuits (ICs) with rapidly increasing fast edge rates, the need for signal integrity analysis has become a vital part of the product development cycle. Signal quality is an important factor in the performance of the overall product, so the need to analyze crosstalk effects, over/undershoot, propagation delays and the evaluation of different termination schemes can help identify problems early in the design process, and avoid unnecessary design failures and costly iterations.

High-speed interfaces such as DDRx and PCI Express demand complex timing requirements that cannot be resolved by applying traditional rules of thumb to secure effective signal quality. CADSTAR SI Verify offers a complete concurrent and post-layout signal integrity solution that enables engineers, layout designers and specialists within a development team to collaborate, organize, constrain, and verify their design in a seamless process. This helps them work more effectively, minimize costs, and improve overall time to market.



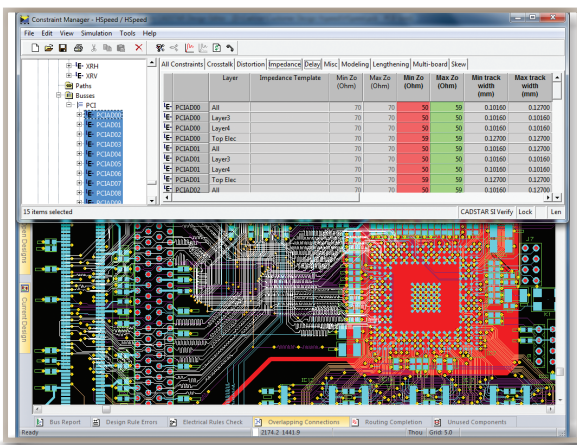
Measure crosstalk effects on coupled traces

Design management and navigation

CADSTAR SI Verify utilizes the constraint manager spreadsheet-style interface to simplify design management, classification and constraint entry.

From the constraint manager, easily generate simulation results within the SI Simulator (waveform viewer) or directly populate the constraint spreadsheet with simulation and measurement results. The design tree view simplifies management and classification of nets and components within a design, and provides easy access to conduct “what-if” analysis to study and determine best strategies for signal termination and topology.

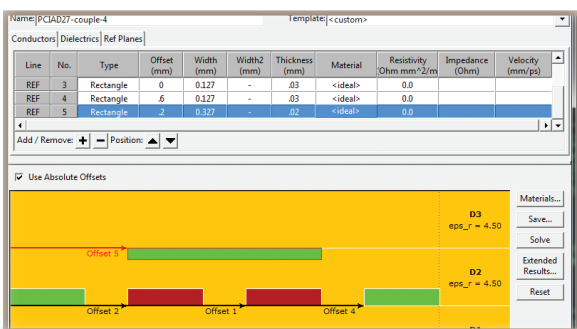
CADSTAR SI Verify includes a standard library of IC models. You can import or build your own models using IBIS, SPICE sub-circuit, or user-defined transmission line/lumped element models to support accurate analysis of critical signals in your design.



Integration with constraint management system for easy access to simulation and constraint verification

Layer stack-up definition

The layer stack-up can be modeled to determine the characteristic impedance of critical transmission lines, accommodating track profile for both rectangular and trapezoidal mode, enabling either the embedded finite element method (FEM) or boundary element method (BEM) field solver and advanced construction materials to achieve accurate results. Frequency-dependent losses and induced crosstalk for coupled lines are included for enhanced accuracy at higher frequencies.

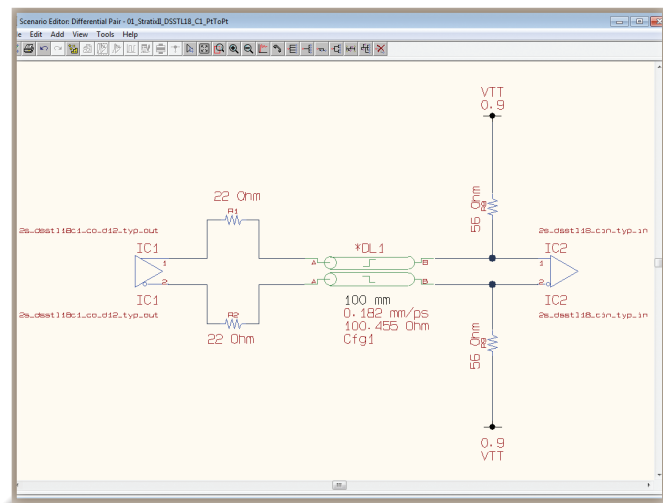


Embedded stack-up planning and impedance calculation

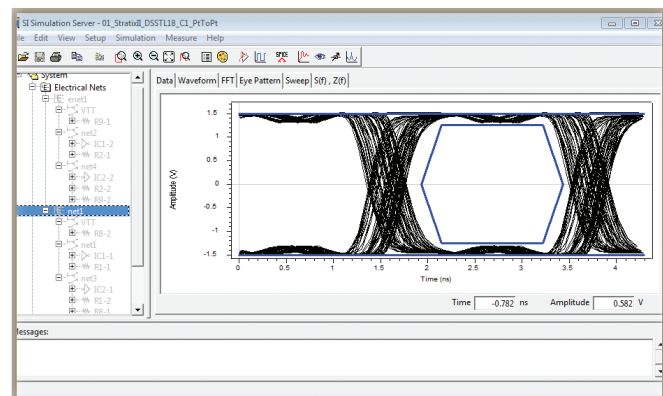
Interactive and batch simulation

CADSTAR SI Verify works in both time and frequency domain modes to analyze transmission lines parameters and provide fast analysis of reflection and crosstalk, in addition to measuring timing and delay characteristics. You can run interactive or batch simulation for single or coupled lines, returning a range of graphical results including:

- Voltage over time
- FFT (Fast Fourier Transformation) to identify frequency-based hot-spots
- Fast eye diagram generation
- Frequency-domain analysis for transmission line impedance and S-Parameter results of the whole interconnect
- Parameter sweeps for discrete values, trace parameters and driver/receiver models for expanded analysis of high-speed interfaces, such as the optimization of on termination (ODT) settings
- Easy-to-use interactive and automatic measurement tools to capture critical points, such rise/fall time and over/undershoot



Conduct “what-if” analysis for determining effective design strategies



Generate eye diagrams and verify against predefined eye masks